

<b>Search Notes</b>  <b>*1058594</b>  <b>3*</b>	<b>Application/Control No.</b>  10585943	<b>Applicant(s)/Patent Under Reexamination</b>  HIRANO ET AL.
	<b>Examiner</b>  Michael Thier	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
	updated	12/27/2010	/mtt/

SEARCH NOTES		
Search Notes	Date	Examiner
updated	12/27/2010	/mtt/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	EAST interference search.	12/27/2010	/mtt/

--	--